

Preliminary

TOSHIBA Transistor Silicon NPN · PNP Epitaxial Type
(PCT Process) (Transistor with Built-in Bias Resistor)

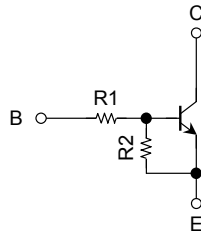
RN49P1FS

Switching, Inverter Circuit, Interface Circuit and Driver
Circuit Applications

- Two devices are incorporated into a fine-pitch, Small-Mold (6-pin) package.
- Incorporating a bias resistor into a transistor reduces the parts count.
Reducing the parts count enables the manufacture of ever more compact equipment and saves assembly costs.
- Lead (Pb) - free

Equivalent Circuit and Bias Resistor Values

Q1



Q1

R1: 10 kΩ, R2: 10 kΩ

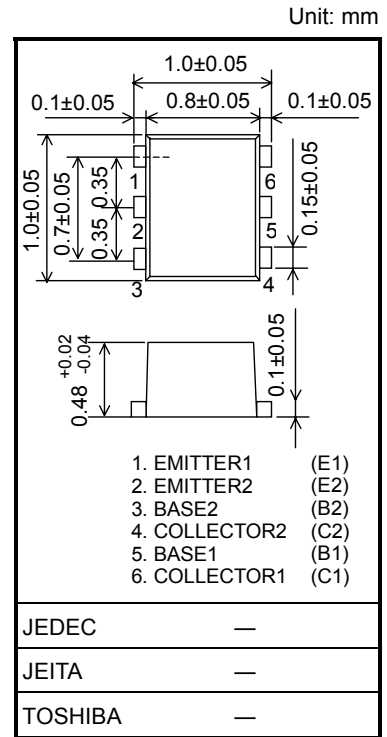
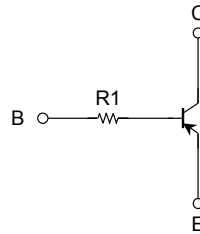
Q2

R1: 10 kΩ

Q1: RN1102FS

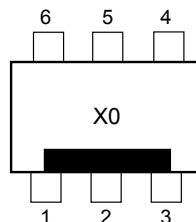
Q2: RN2111FS

Q2

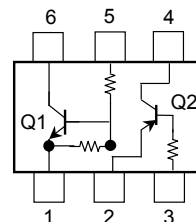


Weight: 0.001 g (typ.)

Marking



Equivalent Circuit (top view)



Maximum Ratings (Ta = 25°C) (Q1)

Characteristic	Symbol	Rating	Unit
Collector-base voltage	V _{CB0}	20	V
Collector-emitter voltage	V _{CE0}	20	V
Emitter-base voltage	V _{EB0}	10	V
Collector current	I _C	50	mA

Maximum Ratings (Ta = 25°C) (Q2)

Characteristic	Symbol	Rating	Unit
Collector-base voltage	V _{CB0}	-20	V
Collector-emitter voltage	V _{CE0}	-20	V
Emitter-base voltage	V _{EB0}	-5	V
Collector current	I _C	-50	mA

Maximum Ratings (Ta = 25°C) (Q1, Q2 common)

Characteristic	Symbol	Rating	Unit
Collector power dissipation	P _C (Note)	50	mW
Junction temperature	T _j	150	°C
Storage temperature range	T _{stg}	-55~150	°C

Note: Total rating

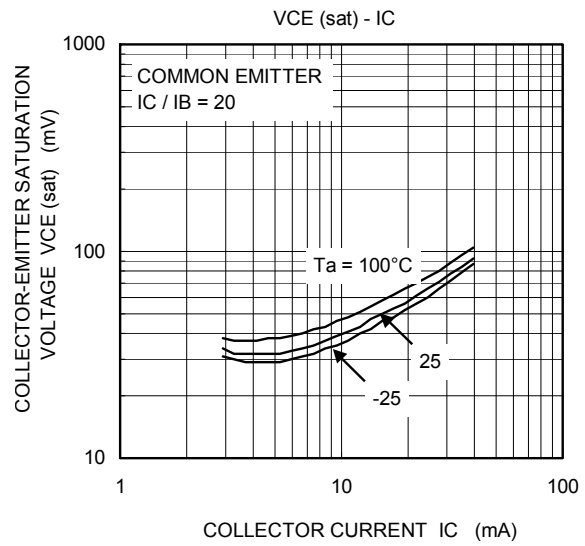
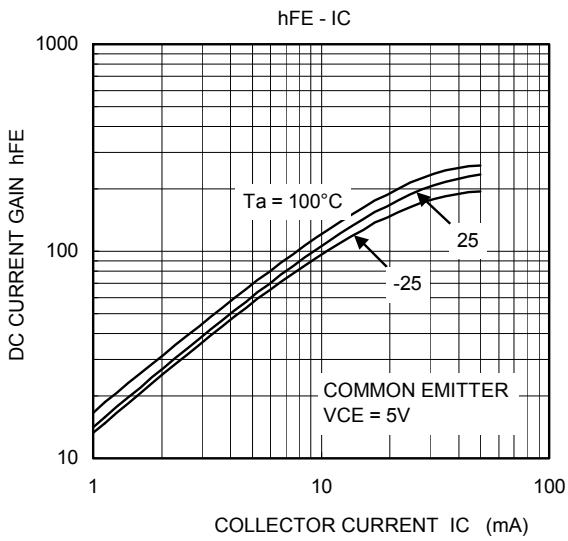
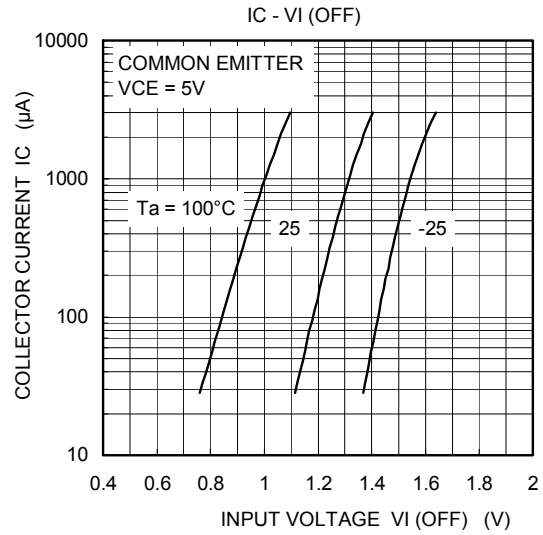
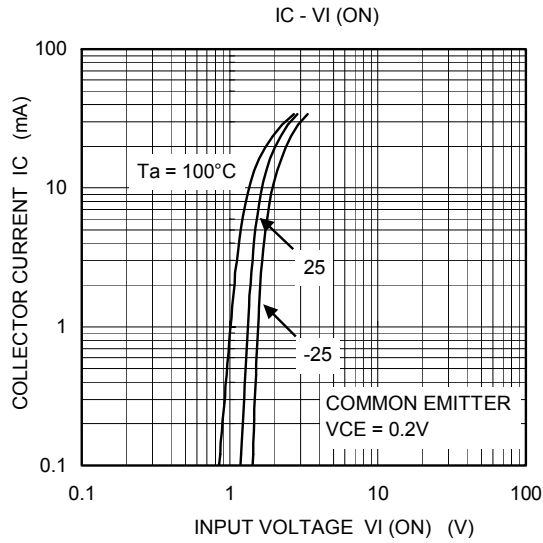
Electrical Characteristics (Ta = 25°C) (Q1)

Characteristic	Symbol	Test Condition	Min	Typ.	Max	Unit
Collector cutoff current	I_{CBO}	$V_{CB} = 20\text{ V}, I_E = 0$	—	—	100	nA
	I_{CEO}	$V_{CE} = 20\text{ V}, I_B = 0$	—	—	500	
Emitter cutoff current	I_{EBO}	$V_{EB} = 10\text{ V}, I_C = 0$	0.41	—	0.63	mA
DC current gain	h_{FE}	$V_{CE} = 5\text{ V}, I_C = 10\text{ mA}$	60	—	—	
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C = 5\text{ mA}, I_B = 0.25\text{ mA}$	—	—	0.15	V
Input voltage (ON)	$V_{I(ON)}$	$V_{CE} = 0.2\text{ V}, I_C = 5\text{ mA}$	1.0	—	2.2	V
Input voltage (OFF)	$V_{I(OFF)}$	$V_{CE} = 5\text{ V}, I_C = 0.1\text{ mA}$	0.8	—	1.5	V
Collector output capacitance	C_{ob}	$V_{CB} = 10\text{ V}, I_E = 0, f = 1\text{ MHz}$	—	1.2	—	pF
Input resistor	R1	—	8	10	12	kΩ
Resistor ratio	R1/R2	—	0.8	1.0	1.2	

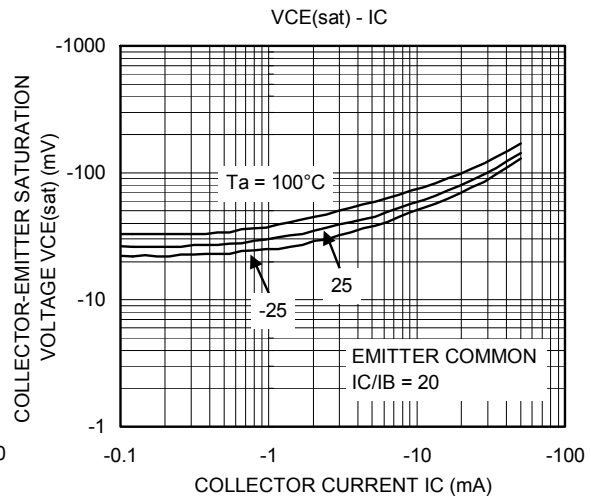
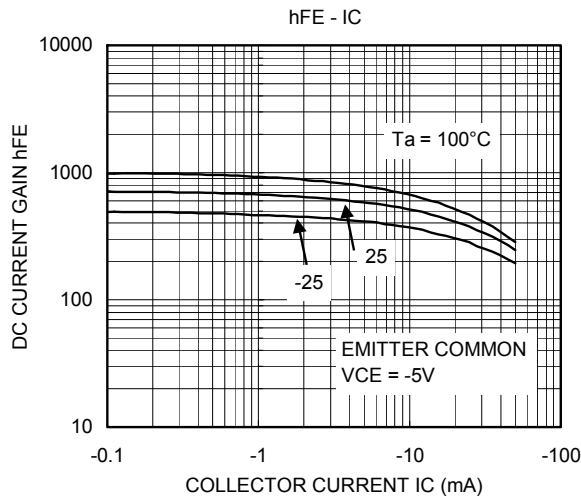
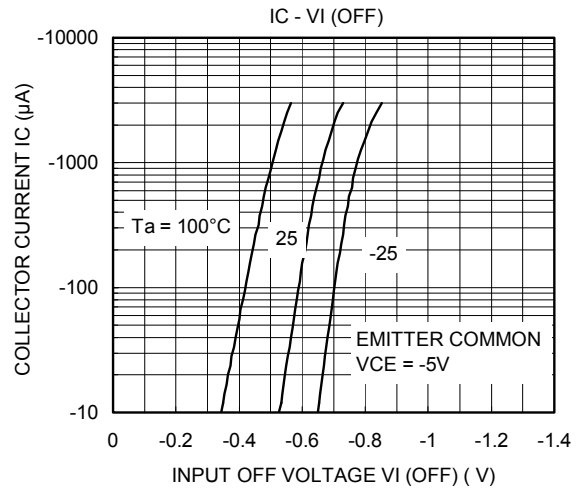
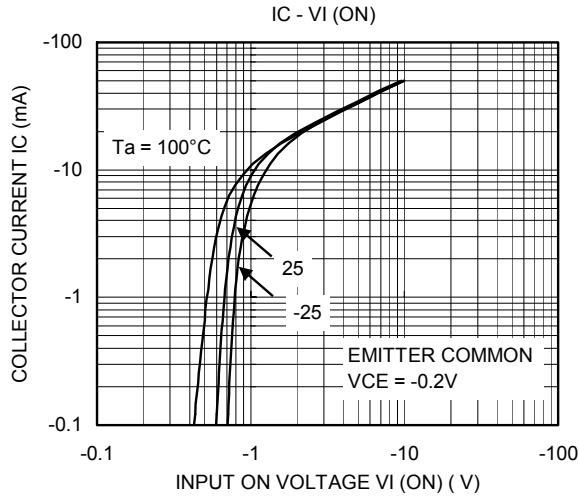
Electrical Characteristics (Ta = 25°C) (Q2)

Characteristic	Symbol	Test Condition	Min	Typ.	Max	Unit
Collector cutoff current	I_{CBO}	$V_{CB} = -20\text{ V}, I_E = 0$	—	—	-100	nA
Emitter cutoff current	I_{EBO}	$V_{EB} = -5\text{ V}, I_C = 0$	—	—	-100	mA
DC current gain	h_{FE}	$V_{CE} = -5\text{ V}, I_C = -1\text{ mA}$	300	—	—	
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C = -5\text{ mA}, I_B = -0.25\text{ mA}$	—	—	-0.15	V
Collector output capacitance	C_{ob}	$V_{CB} = -10\text{ V}, I_E = 0, f = 1\text{ MHz}$	—	1.2	—	pF
Input resistor	R1	—	8	10	12	kΩ

Q1



Q2



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